

3/1/2014/apers
9-16-94
PATENT

2511

Group Art Unit:

Examiner:

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Application of

Seiji SAWADA et al.

Serial No. 08/246,582

Filed: May 19, 1994

TEST CIRCUIT IN CLOCK SYNCHRONOUS SEMICONDUCTOR MEMORY

DEVICE

TRANSMITTAL OF CERTIFIED PRIORITY DOCUMENT

Honorable Commissioner of Patents and Trademarks Washington, D.C. 20231

Sir:

For:

7/5/94 25C Popek 0500

At the time of filing the above-identified application, a claim was made to the priority date(s) of the corresponding

Japanese Patent Application Serial No. 5-122439

filed May 25, 1993

We now submit the priority document(s) in support of this Claim of Priority. Acknowledgement is respectfully requested.

Respectfully submitted,

LOWE, PRICE, LEBLANC & BECKER

Stephen A. Becker Registration No. 26,527

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99 Canal Center Plaza, Suite 300 Alexandria, Virginia 22314 (703) 684-1111 SAB:kh Enclosure Date: June 24, 1994

GROUP 2500